



30V P-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(on)} Max	I _D Max @ T _A = 25°C
-30V	2.4Ω @ V _{GS} = -10V	-250mA
-30 V	4Ω @ V _{GS} = -4.5V	-200mA

Description

This MOSFET has been designed to minimize the on-state resistance $(R_{DS(on)})$ and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- Load Switch
- Portable Applications
- Power Management Functions

Features

- Low On-Resistance
- ESD Protected Gate
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

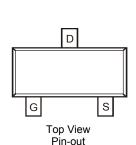
Mechanical Data

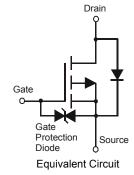
- Case: SOT323
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Lead Free Plating (Matte Tin Finish annealed over Alloy 42 leadframe).
- Weight: 0.006 grams (approximate)











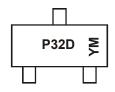
Ordering Information (Note 4)

Product	Marking	Reel size (inches)	Quantity per reel
DMP32D4SW-7	P32D	7	3,000
DMP32D4SW-13	P32D	13	10,000

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http"//www.diodes.com/products/packages.html.

Marking Information



P32D = Product Type Marking Code YM = Date Code Marking Y = Year (ex: Z = 2012) M = Month (ex: 9 = September)

Date Code Key

Year	201	2	2013		2014	20	15	2016		2017	2	2018
Code	Z		Α		В	(D		Е		F
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic			Symbol	Value	Unit
Drain-Source Voltage			V_{DSS}	-30	V
Gate-Source Voltage			V _{GSS}	±20	V
Continuous Drain Current (Note 6)	V _{GS} = -10V	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I _D	250 200	mA
Pulsed Drain Current (Note 6)			I _{DM}	-1	Α

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Units	
Total Power Dissipation	(Note 5)	В	300	mW	
Total Fower Dissipation	(Note 6)	P _D	432	IIIVV	
Thermal Resistance, Junction to Ambient	(Note 5)	D	398		
mermai Resistance, Junction to Ambient	(Note 6)	$R_{\theta JA}$	290	°C/W	
Thermal Resistance, Junction to Case	(Note 5)	$R_{ heta JC}$	142		
Operating and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C	

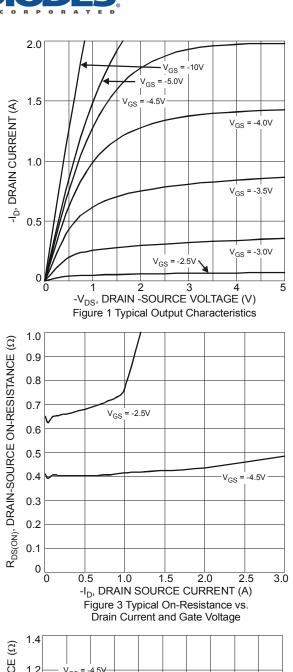
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

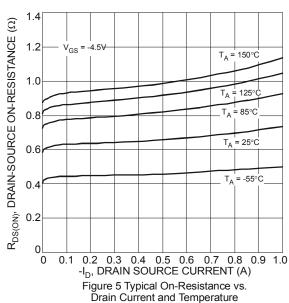
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)						
Drain-Source Breakdown Voltage	BV _{DSS}	-30	-	-	V	$V_{GS} = 0V$, $I_D = -1mA$
Zero Gate Voltage Drain Current T _J = +25°C	I _{DSS}	-	-	-1	μA	$V_{DS} = -30V, V_{GS} = 0V$
Gate-Source Leakage	IGSS	-	-	±10	μΑ	$V_{GS} = \pm 16V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	V _{GS(th)}	-1.4	-	-2.4	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
Static Drain-Source On-Resistance	D	_		2.4	Ω	$V_{GS} = -10V, I_D = -0.5A$
Static Dialii-Source Oil-Resistance	R _{DS (ON)}		-	4	12	$V_{GS} = -4.5V$, $I_D = -0.3A$
Forward Transfer Admittance	Y _{fs}	-	6	-	S	$V_{DS} = -10V, I_D = -400 \text{mA}$
Diode Forward Voltage	V_{SD}	-	0.8	1.2	V	$V_{GS} = 0V, I_{S} = -300 \text{mA}$
DYNAMIC CHARACTERISTICS (Note 8)						
Input Capacitance	C _{iss}	-	51.16	ı	pF	- 45\/ \/ - 0\/
Output Capacitance	Coss	-	10.85	ı	pF	V _{DS} = -15V, V _{GS} = 0V, -f = 1.0MHz
Reverse Transfer Capacitance	C_{rss}	-	8.88	1	pF	1 - 1.0WH12
Gate Resistance	R_{g}	-	275	ı	Ω	V_{DS} = 0V, V_{GS} = 0V, f = 1MHz
Total Gate Charge	Q_g	-	0.6	1	nC	$V_{GS} = -4.5V$
Total Gate Charge	Q_g	-	1.2	ı	nC	$V_{DS} = -10V$,
Gate-Source Charge	Q_{gs}	-	0.2	ı	nC	$V_{GS} = -10V$ $I_{D} = -1A$
Gate-Drain Charge	Q_{gd}	-	0.3	ı	nC	
Turn-On Delay Time	t _{D(on)}	-	9.86	-	ns	
Turn-On Rise Time	tr	-	11.5	ı	ns	V _{DS} = -15V, I _D = -1A
Turn-Off Delay Time	$t_{D(off)}$	-	31.8	-	ns	V_{GS} = -10V, R_G = 6 Ω
Turn-Off Fall Time	t _f	-	21.9	ı	ns	

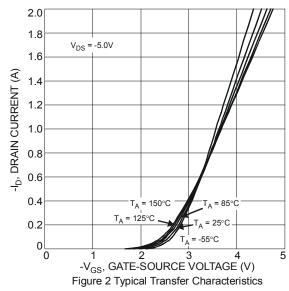
Notes:

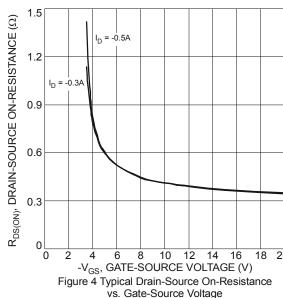
- 5. Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.
- Bevice mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper pad layout
 Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to production testing.

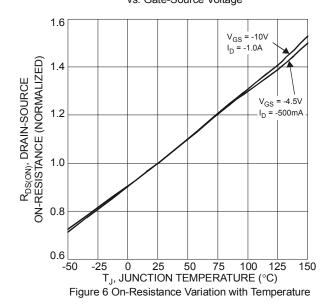




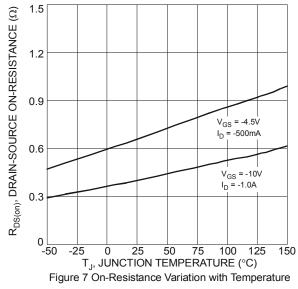


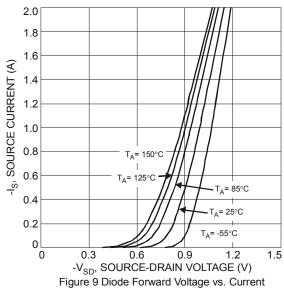


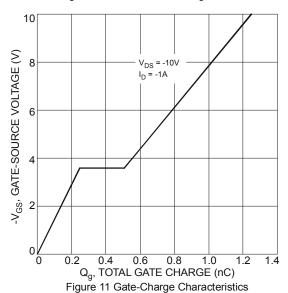












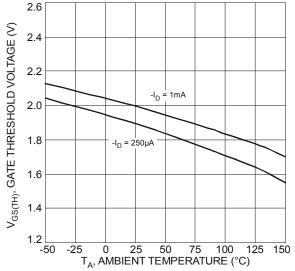
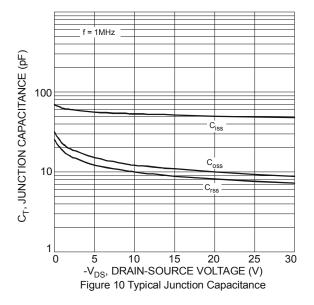


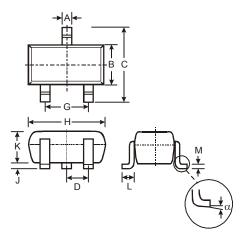
Figure 8 Gate Threshold Variation vs. Ambient Temperature





Package Outline Dimensions

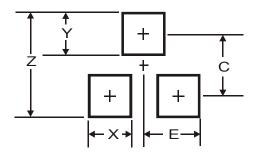
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



	SOT323							
Dim	Min	Max	Тур					
Α	0.25	0.40	0.30					
В	1.15	1.35	1.30					
С	2.00	2.20	2.10					
D	-	-	0.65					
G	1.20	1.40	1.30					
Н	1.80	2.20	2.15					
J	0.0	0.10	0.05					
K	0.90	1.00	0.95					
L	0.25	0.25 0.40 0.3						
M	0.10	0.18	0.11					
α	0°	8°	-					
All	All Dimensions in mm							

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
Z	2.8
Х	0.7
Υ	0.9
С	1.9
E	1.0



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